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Application/Control No.	Applicant(s)/Patent under Reexamination
10/711,996	CHEN ET AL.
Examiner	Art Unit
VAN T. PHAM	2627

SEARCHED			
Class	Subclass	Date	Examiner
none	none	11/28/2007	VP
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB	text search.	11/28/2007	VP
Interference search histo	search (see ory:printout)		

(INCLUDING SEARCH	DATE	EXMR
East (US-PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369 and 369/53.31, 47. (text search only see search history printout).	11/28/2007	VP